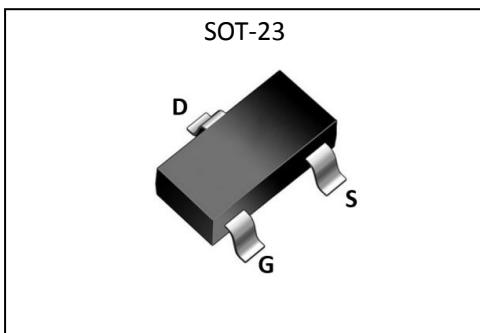


### General Description :

HMZ0202 the silicon N-channel Enhanced VDMOSFETS, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is SOT-23, which accords with the RoHS standard.

|                                  |      |          |
|----------------------------------|------|----------|
| $V_{DSS}$                        | 200  | V        |
| $I_D$                            | 2    | A        |
| $P_D$ ( $T_C=25^\circ\text{C}$ ) | 1.25 | W        |
| $R_{DS(\text{ON})\text{typ}}$    | 2.4  | $\Omega$ |

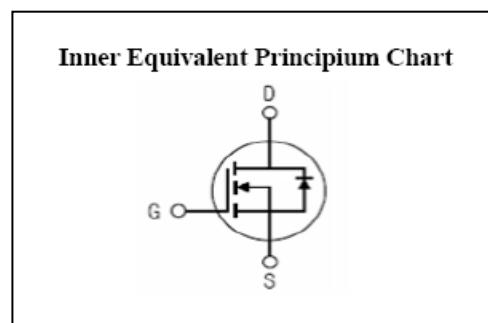


### Features :

- Fast Switching
- Low Gate Charge and  $V_{th}$
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

### Applications :

- LED Lighting
- Charger
- Standby Power



### Absolute ( $T_c=25^\circ\text{C}$ unless otherwise specified ) :

| Symbol            | Parameter  | Rating          | Units            |
|-------------------|--|-----------------|------------------|
| $V_{DSS}$         | Drain-to-Source Voltage                            | 200             | V                |
| $I_D$             | Continuous Drain Current                           | 2               | A                |
|                   | Continuous Drain Current $T_c = 100^\circ\text{C}$ | 1.2             | A                |
| $I_{DM}^{a1}$     | Pulsed Drain Current                               | 5               | A                |
| $V_{GS}$          | Gate-to-Source Voltage                             | $\pm 20$        | V                |
| $E_{AS}^{a2}$     | Single Pulse Avalanche Energy                      | 30              | mJ               |
| $dv/dt^{a3}$      | Peak Diode Recovery $dv/dt$                        | 5.0             | V/ns             |
| $P_D$             | Power Dissipation                                  | 1.25            | W                |
| $T_J$ , $T_{stg}$ | Operating Junction and Storage Temperature Range   | 150, -55 to 150 | $^\circ\text{C}$ |
| $T_L$             | Maximum Temperature for Soldering                  | 300             | $^\circ\text{C}$ |

**Electrical Characteristics ( Tc=25°C unless otherwise specified ) :**

| <b>OFF Characteristics</b>          |                                   |   |        |      |      |       |
|-------------------------------------|-----------------------------------|---|--------|------|------|-------|
| Symbol                              | Parameter                         | Test Conditions   | Rating |      |      | Units |
|                                     |                                   |   | Min.   | Typ. | Max. |       |
| V <sub>DSS</sub>                    | Drain to Source Breakdown Voltage | V <sub>GS</sub> =0V, I <sub>D</sub> =250μA                        | 200    | --   | --   | V     |
| ΔBV <sub>DSS</sub> /ΔT <sub>J</sub> | Bvdss Temperature Coefficient     | I <sub>D</sub> =250uA, Reference 25°C                             | --     | 0.21 | --   | V/°C  |
| I <sub>DSS</sub>                    | Drain to Source Leakage Current   | V <sub>DS</sub> =200V, V <sub>GS</sub> =0V, T <sub>a</sub> =25°C  | --     | --   | 1    | μA    |
|                                     |                                   | V <sub>DS</sub> =160V, V <sub>GS</sub> =0V, T <sub>a</sub> =125°C | --     | --   | 100  |       |
| I <sub>GSS(F)</sub>                 | Gate to Source Forward Leakage    | V <sub>GS</sub> =+30V   | --     | --   | 100  | μA    |
| I <sub>GSS(R)</sub>                 | Gate to Source Reverse Leakage    | V <sub>GS</sub> =-30V   | --     | --   | -100 | μA    |

| <b>ON Characteristics</b>  |                               |  |        |      |      |       |
|----------------------------|-------------------------------|--|--------|------|------|-------|
| Symbol                     | Parameter                     | Test Conditions  | Rating |      |      | Units |
|                            |                               |  | Min.   | Typ. | Max. |       |
| R <sub>DSON</sub>          | Drain-to-Source On-Resistance | V <sub>GS</sub> =4.5V, I <sub>D</sub> =2.0A              | --     | 2.4  | 3.0  | Ω     |
| R <sub>DSON</sub>          | Drain-to-Source On-Resistance | V <sub>GS</sub> =2.5V, I <sub>D</sub> =2.0A              | --     | 2.6  | 3.1  | Ω     |
| V <sub>Gsth</sub>          | Gate Threshold Voltage        | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA | 0.4    | 0.7  | 1.5  | V     |
| Pulse width tp<300μs, δ≤2% |                               |  |        |      |      |       |

| <b>Dynamic Characteristics</b> |                              |   |        |      |      |       |
|--------------------------------|------------------------------|---|--------|------|------|-------|
| Symbol                         | Parameter                    | Test Conditions                                       | Rating |      |      | Units |
|                                |                              |   | Min.   | Typ. | Max. |       |
| g <sub>fs</sub>                | Forward Transconductance     | V <sub>DS</sub> =25V, I <sub>D</sub> =2.0A            | --     | 1.0  | --   | S     |
| C <sub>iss</sub>               | Input Capacitance            | V <sub>GS</sub> =0V, V <sub>DS</sub> =25V<br>f=1.0MHz | --     | 80   | --   | pF    |
| C <sub>oss</sub>               | Output Capacitance           |   | --     | 6    | --   |       |
| C <sub>rss</sub>               | Reverse Transfer Capacitance |   | --     | 2    | --   |       |

| <b>Resistive Switching Characteristics</b> |                                   |   |        |      |      |       |
|--|-----------------------------------|---|--------|------|------|-------|
| Symbol                                     | Parameter                         | Test Conditions   | Rating |      |      | Units |
|  |                                   |   | Min.   | Typ. | Max. |       |
| t <sub>d(ON)</sub>                         | Turn-on Delay Time                | I <sub>D</sub> =2A, V <sub>DD</sub> =100V<br>R <sub>G</sub> =10Ω  | --     | 2    | --   | ns    |
| t <sub>r</sub>                             | Rise Time                         |   | --     | 4    | --   |       |
| t <sub>d(OFF)</sub>                        | Turn-Off Delay Time               |   | --     | 6    | --   |       |
| t <sub>f</sub>                             | Fall Time                         |   | --     | 3    | --   |       |
| Q <sub>g</sub>                             | Total Gate Charge                 | I <sub>D</sub> =2A, V <sub>DD</sub> =100V<br>V <sub>GS</sub> =10V | --     | 2    | --   | nC    |
| Q <sub>gs</sub>                            | Gate to Source Charge             |   | --     | 1    | --   |       |
| Q <sub>gd</sub>                            | Gate to Drain ( "Miller" ) Charge |   | --     | 1.2  | --   |       |

**Source-Drain Diode Characteristics**

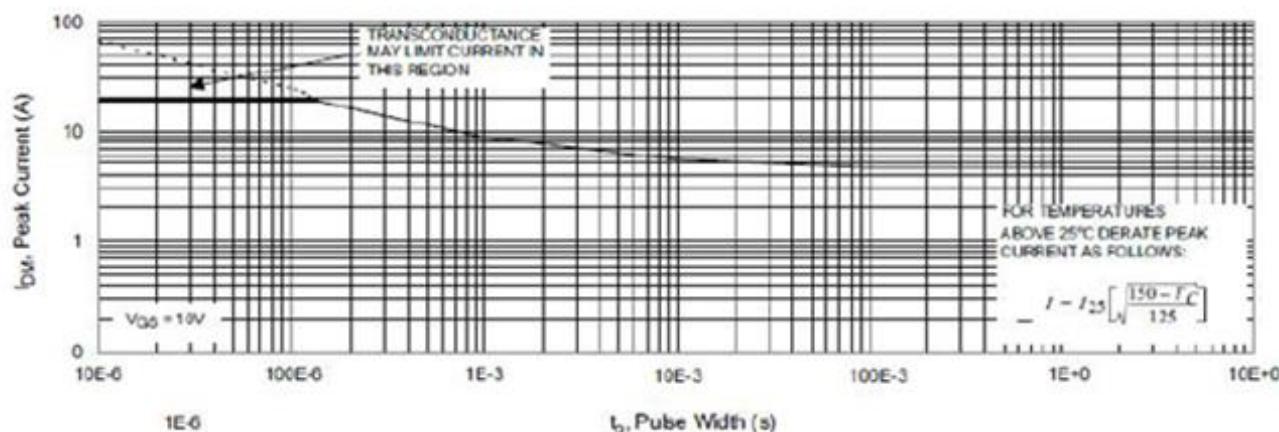
| Symbol   | Parameter                              | Test Conditions            | Rating |      |      | Units   |
|--|--|----------------------------|--------|------|------|---------|
|  |  |                            | Min.   | Typ. | Max. |         |
| $I_S$  | Continuous Source Current (Body Diode) |                            | --     | --   | 2    | A       |
| $I_{SM}$   | Maximum Pulsed Current (Body Diode)    |                            | --     | --   | 5    | A       |
| $V_{SD}$   | Diode Forward Voltage                  | $I_S=2.0A, V_{GS}=0V$      | --     | --   | 1.5  | V       |
| $t_{rr}$   | Reverse Recovery Time                  | $I_S=2.0A, T_j=25^\circ C$ | --     | 50   | --   | ns      |
| $Q_{rr}$   | Reverse Recovery Charge                | $dI_F/dt=100A/\mu s$ ,     | --     | 40   | --   | $\mu C$ |
| $I_{RRM}$  | Reverse Recovery Current               | $V_{GS}=0V$                | --     | 1    | --   | A       |
| Pulse width $t_p \leq 300\mu s, \delta \leq 2\%$ |  |                            |        |      |      |         |

| Symbol          | Parameter           | Typ. | Units        |
|-----------------|---------------------|------|--------------|
| $R_{\theta JA}$ | Junction-to-Ambient | 100  | $^\circ C/W$ |

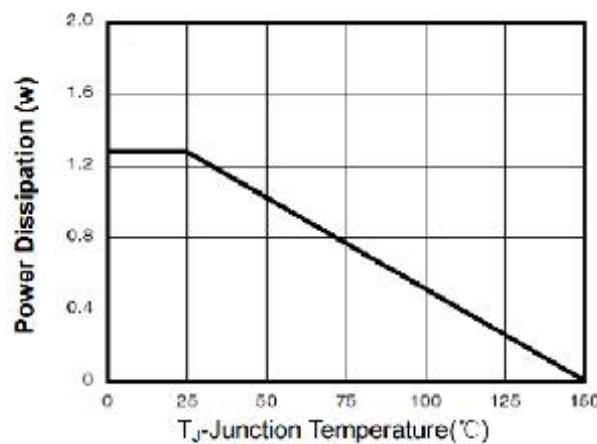
<sup>a1</sup> : Repetitive rating; pulse width limited by maximum junction temperature

<sup>a2</sup> : L=10.0mH,  $I_D=1A$ , Start  $T_j=25^\circ C$ 
<sup>a3</sup> :  $I_{SD} = 5A, dI/dt \leq 100A/\mu s, V_{DD} \leq BV_{DS}$ , Start  $T_j=25^\circ C$

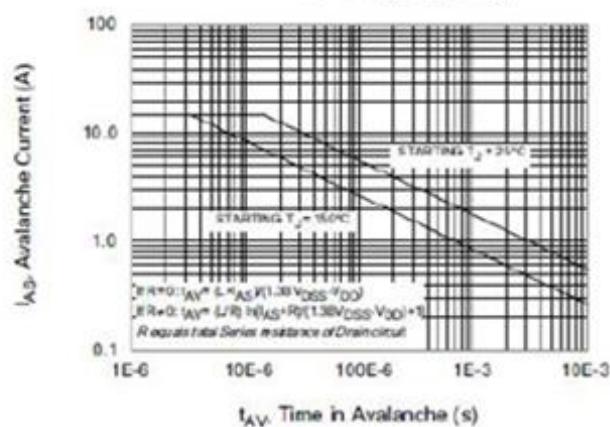
**Figure 6. Maximum Peak Current Capability**



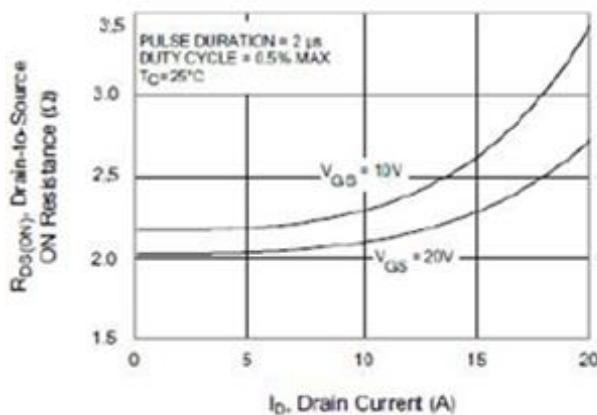
**Figure 7. Typical Transfer Characteristics**



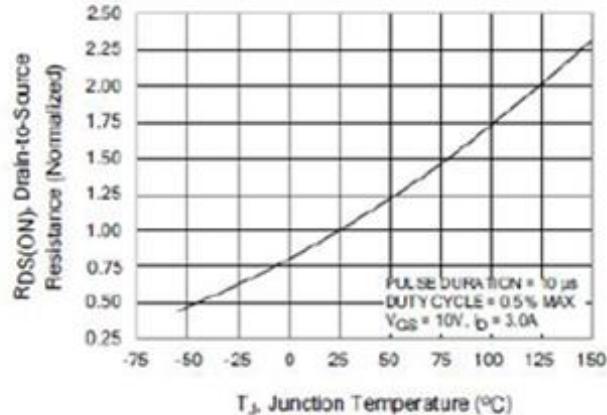
**Figure 8. Unclamped Inductive Switching Capability**



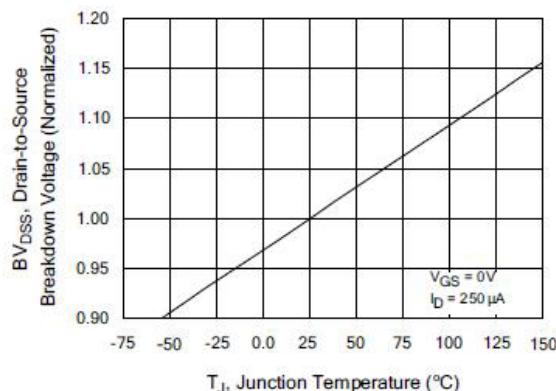
**Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current**



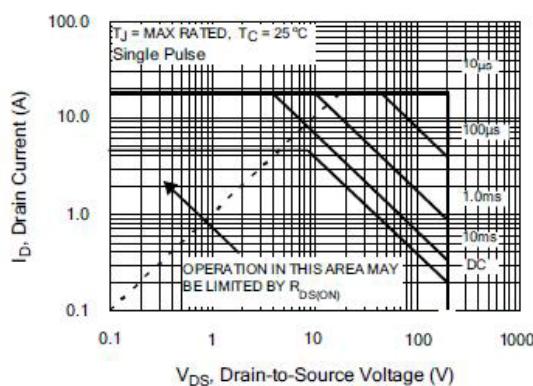
**Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature**



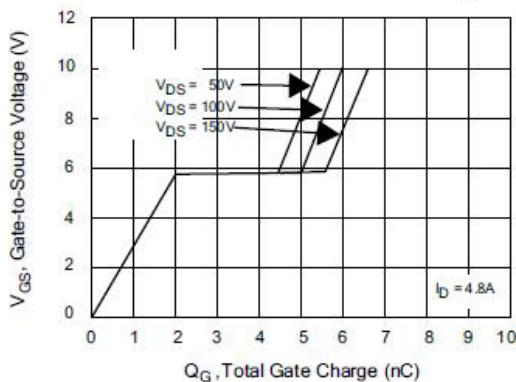
**Figure 11. Typical Breakdown Voltage vs Junction Temperature**



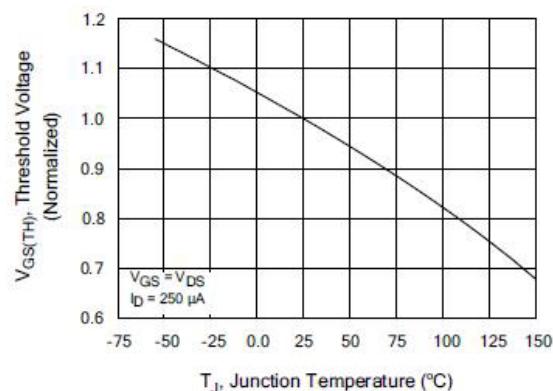
**Figure 13. Maximum Forward Bias Safe Operating Area**



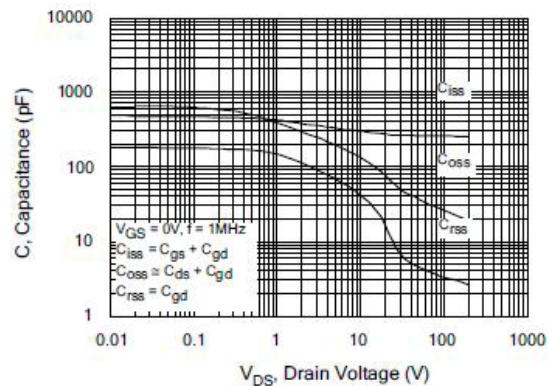
**Figure 15. Typical Gate Charge vs Gate-to-Source Voltage**



**Figure 12. Typical Threshold Voltage vs Junction Temperature**



**Figure 14. Typical Capacitance vs Drain-to-Source Voltage**



**Figure 16. Typical Body Diode Transfer Characteristics**

